Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
09/787,668	DEHAAN ET AL.
Examiner	Art Unit
Tam M. Nguyen	1764

SEARCHED					
Class	Subclass	Date	Examiner		
208 44 58	UPDATED	4/15/2006	TN		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED - SEE PGPUB PRINTOUT.	6/17/2006	TN	
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